	Application No.	Applicant(s)	Applicant(s)	
Notice of Allowability	10/671,642	SUTHERLAND ET	SUTHERLAND ET AL.	
	Examiner	Art Unit		
	Jasmine J Clark	2815	_	
The MAILING DATE of this communication appe All claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RI of the Office or upon petition by the applicant. See 37 CFR 1.313	(OR REMAINS) CLOSED or other appropriate comm GHTS. This application is	in this application. If not include nunication will be mailed in due	ed course. <b>THIS</b>	
1. $\boxtimes$ This communication is responsive to <u>08/16/04</u> .				
2. X The allowed claim(s) is/are 1-12, 25-36; renumbered to 1-2	<u>24</u> .		,	
3. $\boxtimes$ The drawings filed on <u>26 September 2003</u> are accepted by	the Examiner.			
<ul> <li>4. Acknowledgment is made of a claim for foreign priority una)</li> <li>a) All b) Some* c) None of the:</li> <li>1. Certified copies of the priority documents have</li> <li>2. Certified copies of the priority documents have</li> <li>3. Copies of the certified copies of the priority documents have</li> <li>International Bureau (PCT Rule 17.2(a)).</li> <li>* Certified copies not received:</li> <li>Applicant has THREE MONTHS FROM THE "MAILING DATE" on the priority documents have</li> <li>Applicant has THREE MONTHS FROM THE "MAILING DATE" on the priority documents have</li> <li>THREE-MONTH PERIOD IS NOT EXTENDABLE.</li> </ul>	been received. been received in Application cuments have been received	on No ed in this national stage applica		
5. A SUBSTITUTE OATH OR DECLARATION must be subminification (PTO-152) which give			IOTICE OF	
<ol> <li>CORRECTED DRAWINGS (as "replacement sheets") mus         <ul> <li>(a) including changes required by the Notice of Draftspers</li> <li>1) hereto or 2) to Paper No./Mail Date</li> <li>(b) including changes required by the attached Examiner's Paper No./Mail Date</li> <li>Identifying indicia such as the application number (see 37 CFR 1. each sheet. Replacement sheet(s) should be labeled as such in the deposit of the position of the deposit of the deposit</li></ul></li></ol>	on's Patent Drawing Reviews  Amendment / Comment of  S4(c)) should be written on the header according to 37 Cesit of BIOLOGICAL MAT	or in the Office action of the drawings in the front (not the FR 1.121(d). 'ERIAL must be submitted. I		
<ul> <li>Attachment(s)</li> <li>1.  Notice of References Cited (PTO-892)</li> <li>2.  Notice of Draftperson's Patent Drawing Review (PTO-948)</li> <li>3.  Information Disclosure Statements (PTO-1449 or PTO/SB/0 Paper No./Mail Date 09/26/03</li> <li>4.  Examiner's Comment Regarding Requirement for Deposit of Biological Material</li> </ul>	6. Interview S Paper No 8), 7. Examiner's	nformal Patent Application (PTG Summary (PTO-413), ./Mail Date s Amendment/Comment s Statement of Reasons for Allo  JASMINE CL PRIMARY EXA	owance ARK	

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## Information Disclosure Statement

1. The Information Disclosure Statement filed 09/26/03 has been fully considered.

## References Cited

2. Ma et al. (US 6,586,836 B1) show a structure of a semiconductor device comprising (see Figs. 5C and 6) a first die, eg, 102 disposed on one substrate, and a second die 102' disposed on another substrate, where the fist die and second die are attached to each other with an adhesive layer 164. However, Ma fails to teach wherein the first semiconductor die and the second semiconductor die are arranged active face to active face so that signal pads on the first die overlap with signal pads on the second semiconductor die. Heo (US 6,555,917 B1) shows a first semiconductor die and a second semiconductor die arranged active face to active face, but fails to teach wherein the first semiconductor die and the second semiconductor die are pressed together between a first substrate and a second substrate so that the front face of the first substrate is in contact with the back face of the first semiconductor die and the front face of the second substrate is in contact with the back face of the second semiconductor die. Please also see Hofstee et al. (US 6,507,115 B2), Wojnarowski et al. (US 5,703,400), Nicewarner et al. (US 5,491,612), Masuda et al. (US 6,555,918 B2), and Song et al. (US 6,552,423 B2).

## Allowable Subject Matter

3. Claims 1-12, 25-36 are allowed.

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The following is an examiner's statement of reasons for allowance: the prior art(s) fail to teach and/or suggest the limitations as set forth in claims 1 and 25.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

## Telephone Inquiry Contacts

4. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Jasmine J Clark whose telephone number is (571) 272-1726. The examiner can normally be reached on Flex.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Tom Thomas can be reached on (571) 272-1664. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Jjbc/09/02/04

JASMINE CLARK
PRIMARY EXAMINER

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